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I hereby certify that this Status Request is being electronically filed on May 19, 2008 with the Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450

 / Ruth Montalvo Date: 05/19/2008

Customer No. 26418

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

Docket No.: GK-ZEI-33303500343.20324

Applicant(s): Adolf FERCHER

Confirmation No.: 2703

Application No.: 10/586,220

Examiner:

Filed: July 17, 2006

Group: 2877

For: SHORT-COHERENCE INTERFEROMETRIC MEASUREMENT OF LENGTH ON THE EYE

Commissioner for Patents  
P. O. Box 1450  
Alexandria, VA 22313-1450

**STATUS REQUEST**

Sir:

Please advise the status of the above-identified application and when we can expect to receive an 371 Acceptance Letter and Filing Receipt.

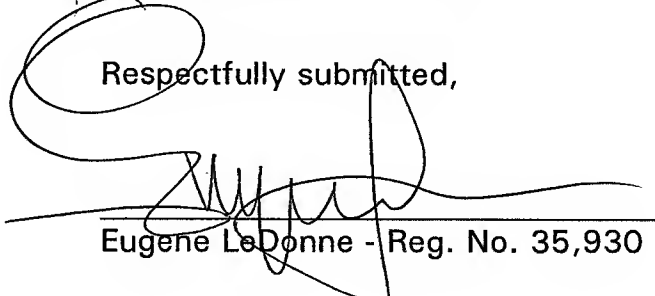
Please direct all future telephone calls and/or correspondence to:

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Respectfully submitted,

May 19, 2008  
ELD:ram

  
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